Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/772,422	KIM ET AL.
Examiner	Art Unit
Shin-Hon Chen	2131

SEARCHED			
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH) -
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	5/11/2007	S.C.